

October 1987 Revised January 1999

CD4007C

Dual Complementary Pair Plus Inverter

General Description

The CD4007C consists of three complementary pairs of N-and P-channel enhancement mode MOS transistors suitable for series/shunt applications. All inputs are protected from static discharge by diode clamps to $V_{\mbox{\scriptsize DD}}$ and $V_{\mbox{\scriptsize SS}}.$

For proper operation the voltages at all pins must be constrained to be between $\rm V_{SS}-0.3V$ and $\rm V_{DD}+0.3V$ at all times.

Features

■ Wide supply voltage range: 3.0V to 15V
 ■ High noise immunity: 0.45 V_{CC} (typ.)

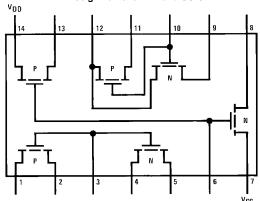
Ordering Code:

Order Number	Package Number	Package Description			
CD4007CM	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150" Narrow			
CD4007CN	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide			

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Connection Diagram





 $\textbf{Note:} \ \textbf{All P-channel substrates are connected to V}_{DD} \ \textbf{and all N-channel substrates are connected to V}_{SS}.$

Top View

Absolute Maximum Ratings(Note 1)

Voltage at Any Pin ${\rm V_{SS}} - 0.3 {\rm V} \ {\rm to} \ {\rm V_{DD}} + 0.3 {\rm V}$ Operating Temperature Range $- 40 {\rm ^{\circ}C} \ {\rm to} + 85 {\rm ^{\circ}C}$

Storage Temperature Range -65°C to +150°C

Power Dissipation (P_D)

 Dual-In-Line
 700 mW

 Small Outline
 500 mW

Operating $V_{\rm DD}$ Range Lead Temperature

(Soldering, 10 seconds)

 $\rm V_{SS}$ +3.0V to $\rm V_{SS}$ +15V

260°C

Note 1: This device should not be connected to circuits with the power on because high transient voltages may cause permanent damage.

DC Electrical Characteristics

		Conditions	Limits									
Symbol	Parameter		-40°C		+25°C			+85°C			Units	
			Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	1
IL	Quiescent Device	V _{DD} = 5.0V			0.5		0.005	0.05			15	μА
	Current	$V_{DD} = 10V$			1.0		0.005	1.0			30	μΑ
P _D	Quiescent Device	V _{DD} = 5.0V			2.5		0.025	2.5			75	μW
	Dissipation Package	$V_{DD} = 10V$			10		0.05	10			300	μW
V _{OL}	Output Voltage	V _{DD} = 5.0V			0.05		0	0.01			0.05	V
	LOW Level	$V_{DD} = 10V$			0.05		0	0.01			0.05	V
V _{OH}	Output Voltage	V _{DD} = 5.0V	4.95			4.95	5.0		4.95			V
	HIGH Level	$V_{DD} = 10V$	9.95			9.95	10		9.95			V
V _{NL}	Noise Immunity	$V_{DD} = 5.0V, V_{O} = 3.6V$			1.5		2.25	1.5			1.4	V
	(All inputs)	$V_{DD} = 10V, V_{O} = 7.2V$			3.0		4.5	3.0			2.9	V
V _{NH}	Noise Immunity	$V_{DD} = 5.0V, V_{O} = 0.95V$	3.6			3.5	2.25		3.5			V
	(All Inputs)	$V_{DD} = 10V, V_{O} = 2.9V$	7.1			7.0	4.5		7.0			V
I _D N	Output Drive Current	$V_{DD} = 5.0V, V_{O} = 0.4V, V_{I} = V_{DD}$	0.35			0.3	1.0		0.24			mA
	N-Channel	$V_{DD} = 10V, V_{O} = 0.5V, V_{I} = V_{DD}$	1.2			1.0	2.5		0.8			mA
I _D P	Output Drive Current	$V_{DD} = 5.0V, V_{O} = 2.5V, V_{I} = V_{SS}$	-1.3			-1.1	-4.0		-0.9			mA
	P-Channel	$V_{DD} = 10V, V_{O} = 9.5V, V_{I} = V_{SS}$	-0.65			-0.55	-2.5		-0.45			mA
I _I	Input Current						10					pА

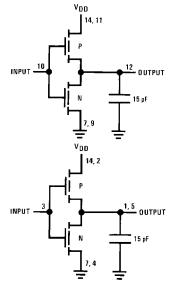
AC Electrical Characteristics (Note 2)

 $T_A = 25^{\circ}C$ and $C_L = 15$ pF and rise and fall times = 20 ns. Typical temperature coefficient for all values of $V_{DD} = 0.3\%/^{\circ}C$

Symbol	Parameter	Conditions	Min	Тур	Max	Units
$t_{PLH} = t_{PHL}$	Propagation Delay Time	V _{DD} = 5.0V		35	75	ns
		$V_{DD} = 10V$		20	50	ns
$t_{TLH} = t_{THL}$	Transition Time	V _{DD} = 5.0V		50	100	ns
		$V_{DD} = 10V$		30	50	ns
C _I	Input Capacitance	Any Input		5		pF

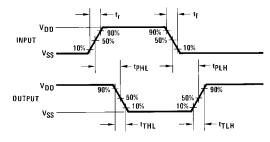
Note 2: AC Parameters are guaranteed by DC correlated testing.

AC Test Circuits

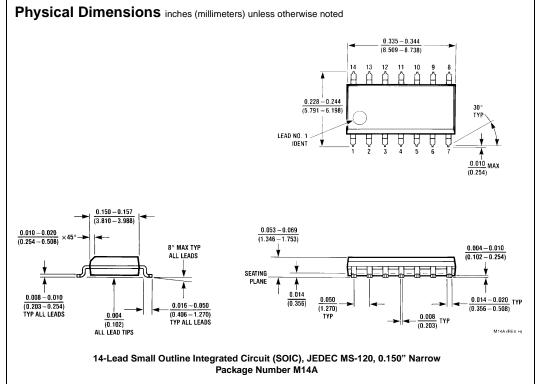


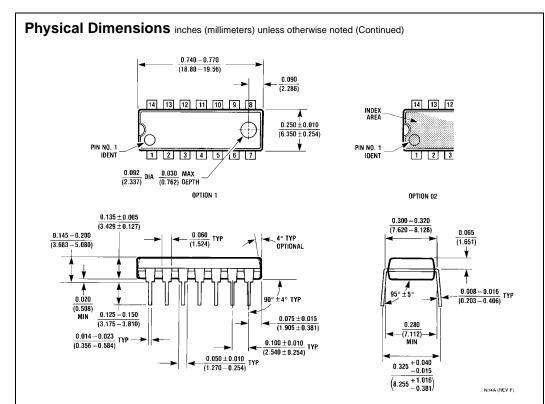
1NPUT 6 P 8, 13 OUTPU 15 pF

Switching Time Waveforms



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14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide Package Number N14A

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